Japan Electronics and Information Technology Industries Association

JEITA EDR-4708C
Guideline for IC Reliability Qualification Plan

## CORRIGENDA

| Original |  |  |  |  |  | Corrected |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Page 32 <br> Table 11-1 Example of trial calculation of equivalent time in the operating life test with consideration of the mission profile (Application in automotive cabin peripherals) |  |  |  |  |  | Page 32 <br> Table 11-1 Example of trial calculation of equivalent time in the operating life test with consideration of the mission profile (Application in automotive cabin peripherals) |  |  |  |  |  |
| Mission profile |  |  | Test settings | Operating time converted to equivalent under accelerated settings |  | Mission profile |  |  | Test settings | Operating time converted to equivalent under accelerated settings |  |
| $T_{\mathrm{a}}$ | $T_{\mathrm{j}}\left({ }^{* 1}\right.$ ) | Operating time |  | $125^{\circ} \mathrm{C}$ temperature acceleration (*2) only | $125^{\circ} \mathrm{C}$ temperature acceleration (*2) <br> 3.63 V voltage acceleration (*3) | $T_{\text {a }}$ | $T_{\mathrm{j}}\left({ }^{* 1}\right.$ ) | Operating time |  | $125^{\circ} \mathrm{C}$ temperature acceleration (*2) only | $125^{\circ} \mathrm{C}$ temperature acceleration (*2) <br> 3.63 V voltage acceleration (*3) |
| $0^{\circ} \mathrm{C}$ | $20^{\circ} \mathrm{C}$ | 400 h | $\begin{aligned} & 125^{\circ} \mathrm{C} \\ & 3.63 \mathrm{~V} \end{aligned}$ <br> (Voltage in actual use $3.3 \mathrm{~V})$ | 0.3 h | 0.1 h | $0^{\circ} \mathrm{C}$ | $20^{\circ} \mathrm{C}$ | 400 h | $\begin{aligned} & 125^{\circ} \mathrm{C} \\ & 3.63 \mathrm{~V} \end{aligned}$ <br> (Voltage in actual use $3.3 \mathrm{~V})$ | 0.3 h | 0.1 h |
| $30^{\circ} \mathrm{C}$ | $50^{\circ} \mathrm{C}$ | 1800 h |  | 15.8 h | 4.2 h | $30^{\circ} \mathrm{C}$ | $50^{\circ} \mathrm{C}$ | 1800 h |  | 15.8 h | 4.2 h |
| $50^{\circ} \mathrm{C}$ | $75^{\circ} \mathrm{C}$ | 1100 h |  | 41.8 h | 11.2 h | $50^{\circ} \mathrm{C}$ | $70^{\circ} \mathrm{C}$ | 1100 h |  | 41.8 h | 11.2 h |
| $65^{\circ} \mathrm{C}$ | $85^{\circ} \mathrm{C}$ | 4200 h |  | 430.1 h | 114.9 h | $65^{\circ} \mathrm{C}$ | $85^{\circ} \mathrm{C}$ | 4200 h |  | 430.1 h | 114.9 h |
| Cumulative total |  | 7500 h |  | 488 h | 130.4 h | Cumulative total |  | 7500 h |  | 488 h | 130.4 h |


| Original |  |  |  | Corrected |  |  |  |
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| Page 37 <br> Table 14-1 Example of trial calculation of equivalent time in the temperature cycle test, <br> with consideration of the mission profile <br> (Application in the automotive engine peripherals) |  |  |  | Page 37 <br> Table 14-1 Example of trial calculation of equivalent time in the temperature cycle test, with consideration of the mission profile (Application in the automotive engine peripherals) |  |  |  |
| Mission profile |  | Test settings | Conversion of actual number of cycles to it is equivalent under accelerated conditions | Mission profile |  | Test settings | Conversion of actual number of cycles to it is equivalent under accelerated conditions |
| $\Delta T$ | Number of cycles |  |  | $\Delta T$ | Number of cycles |  |  |
| $85^{\circ} \mathrm{C}$ | 10950 cycles | $\begin{gathered} 150^{\circ} \mathrm{C} \sim \\ -55^{\circ} \mathrm{C} \\ (\Delta T= \\ \left.205^{\circ} \mathrm{C}\right) \end{gathered}$ | 29.4 cycles | $85^{\circ} \mathrm{C}$ | 10950 cycles | $\begin{gathered} 150^{\circ} \mathrm{C} \sim \\ -55^{\circ} \mathrm{C} \\ (\Delta T= \\ \left.205^{\circ} \mathrm{C}\right) \end{gathered}$ | 323.6 cycles |
| $33^{\circ} \mathrm{C}$ | 43800 cycles |  | 323.6 cycles | $33^{\circ} \mathrm{C}$ | 43800 cycles |  | 29.4 cycles |
| Cumulative total | 54750 cycles |  | 353.1 cycles | Cumulative total | 54750 cycles |  | 353.1 cycles |


| Original | Page 44 | 10 Calculation examples for mission profiles (sample lifetime test and test time calculation) |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Test time | $\underset{\substack{\text { Mission } \\ \text { profile }}}{ }$ |  | Acceleration settings/projected failure |  | Acceleration model |  | EDR-4708C Derived sample Size/time <br> 0.1-Lifetime@CL90 \% | AEC-Q100 Regulation sample size/time LTPD criteria |
|  |  |  | EDR-4708C | AEC-Q100 | EDR-4708C | AEC-Q100 | EDR-4708C | AEC-Q100 |  |  |
|  |  | High-temperature operating life test (EDR-4708C Comparison of engine-area application (1) and AEC-Q100) | 15 yrs/3.3 V $20^{\circ} \mathrm{C} / 500 \mathrm{~h}$ $75^{\circ} \mathrm{C} / 1000 \mathrm{~h}$ $105^{\circ} \mathrm{C} / 4500 \mathrm{~h}$ $125^{\circ} \mathrm{C} / 1000 \mathrm{~h}$ $145^{\circ} \mathrm{C} / 500 \mathrm{~h}$ Operating time Total: 7500 hr | $\begin{array}{c\|} 15 \text { yrs } \\ 87^{\circ} \mathrm{C} / 12000 \mathrm{~h} \\ \hline \end{array}$ | $\begin{gathered} \text { TDDB } \\ \mathrm{Ea}=0.7 \mathrm{eV} \\ \beta=4 \\ 125^{\circ} \mathrm{C} \\ 3.96 \mathrm{~V} \end{gathered}$ | $\begin{gathered} \mathrm{Ea}=0.7 \mathrm{eV} \\ 125^{\circ} \mathrm{C} \end{gathered}$ | $\begin{gathered} a_{1}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\} \\ a=\exp \left\{\beta\left(V_{2}-V_{1}\right)\right\} \end{gathered}$ | $\left.a_{T}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\}\right\}$ | 231 pcs/512 h 31 pcs/1000 h | $\begin{array}{\|c\|} 231 \text { pcs } / 1000 \mathrm{~h} \\ (1394 \mathrm{~h}) \end{array}$ |
|  |  | High-temperature operating life test (EDR-4708C Comparison of engine-area application (2) and AEC-Q100) | $15 \mathrm{yrs} / 3.3 \mathrm{~V}$ $200^{\circ} \mathrm{C} / 500 \mathrm{~h}$ $75^{\circ} / 550 \mathrm{~h}$ $105^{\circ} \mathrm{C} / 8000 \mathrm{~h}$ $125^{\circ} \mathrm{C} 2000 \mathrm{~h}$ $145^{\circ} \mathrm{C} / 10000 \mathrm{~h}$ Operating time Total: 12000 hr | $\begin{array}{c\|} 15 \text { yrs } \\ 87^{\circ} \mathrm{C} / 12000 \mathrm{~h} \end{array}$ | $\begin{gathered} \text { TDDB } \\ \mathrm{Ea}=0.7 \mathrm{eV} \\ \beta=4 \\ 125^{\circ} \mathrm{C} \\ 3.96 \mathrm{~V} \end{gathered}$ | $\begin{gathered} \mathrm{Ea}=0.7 \mathrm{eV} \\ 125^{\circ} \mathrm{C} \end{gathered}$ | $\begin{gathered} a_{\mathrm{T}}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\} \\ a_{r}=\exp \left\{\beta\left(V_{2}-V_{1}\right)\right\} \end{gathered}$ | $\left.a_{T}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{T_{1}}-\frac{1}{T_{2}}\right)\right\}\right\}$ | 231 pcs/969 h $339 \mathrm{pcs} / 1000 \mathrm{~h}$ | $\begin{array}{\|c\|} 231 \mathrm{pcs} / 1000 \mathrm{~h} \\ (1394 \mathrm{~h}) \end{array}$ |
| Corrected | Page 44 | 10 Calculation examples for mission profiles (sample lifetime test and test time calculation) |  |  |  |  |  |  |  |  |
|  |  | $\square$ |  |  | Acceleration se fail | ings/projected e | Accelerati | ion model | EDR-4708C | AEC-Q100 Regulation |
|  |  | me | EDR-4708C | AEC-Q100 | EDR-4708C | AEC-Q100 | EDR-4708C | AEC-Q100 | Size/time <br> 0.1-Lifetime@CL90 \% | $\begin{gathered} \text { sample } \\ \text { sizeftime } \\ \text { LTPD criteria } \\ \hline \end{gathered}$ |
|  |  | High-temperature operating life test (EDR-4708C Comparison of engine-area application (1) and AEC-Q100) | $15 \mathrm{yrs} / 3.3 \mathrm{~V}$ $20^{\circ} \mathrm{C} / 500 \mathrm{~h}$ $75^{\circ} \mathrm{C} / 1000 \mathrm{~h}$ $105^{\circ} \mathrm{C} / 4500 \mathrm{~h}$ $125^{\circ} \mathrm{C} / 1000 \mathrm{~h}$ $145^{\circ} \mathrm{C} / 500 \mathrm{~h}$ Operating time Total: 7500 hr | $\begin{array}{c\|} 15 \text { yrs } \\ 87^{\circ} \mathrm{C} / 12000 \mathrm{~h} \\ \hline \end{array}$ | $\begin{gathered} \text { TDDB } \\ \mathrm{Ea}=0.7 \mathrm{eV} \\ \beta=4 \\ 125{ }^{\circ} \mathrm{C} \\ 3.96 \mathrm{~V} \end{gathered}$ | $\begin{gathered} \mathrm{Ea}=0.7 \mathrm{eV} \\ 125^{\circ} \mathrm{C} \end{gathered}$ | $\begin{gathered} a_{\mathrm{T}}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\} \\ a=\exp \left\{\beta\left(V_{2}-V_{i}\right)\right\} \end{gathered}$ | $\alpha_{T}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\}$ | 231 pcs/601 h $52 \mathrm{pcs} / 1000 \mathrm{~h}$ | ${\underset{y}{21} 23 \mathrm{pcs} / 1000 \mathrm{~h}}_{(1394 \mathrm{~h})}$ |
|  |  | High-temperature operating life test (EDR-4708C Comparison of engine-area application (2) and AEC-Q100) | $15 \mathrm{yrs} / 3.3 \mathrm{~V}$ $20^{\circ} \mathrm{C} / 500 \mathrm{~h}$ $75^{\circ} \mathrm{C} / 500 \mathrm{~h}$ $105^{\circ} \mathrm{C} / 8000 \mathrm{~h}$ $125^{\circ} \mathrm{C} / 2000 \mathrm{~h}$ $145^{\circ} \mathrm{C} / 1000 \mathrm{~h}$ Operating time Total: 12000 hr | $\begin{array}{c\|} 15 \text { yrs } \\ 87^{\circ} \mathrm{C} / 12000 \mathrm{~h} \\ \hline \end{array}$ | $\begin{gathered} \text { TDDB } \\ \mathrm{Ea}=0.7 \mathrm{eV} \\ \beta=4 \\ 1255^{\circ} \mathrm{C} \\ 3.96 \mathrm{~V} \end{gathered}$ | $\begin{gathered} \mathrm{Ea}=0.7 \mathrm{eV} \\ 125^{\circ} \mathrm{C} \end{gathered}$ | $\begin{aligned} a_{T} & =\exp \left\{\frac{E_{s}}{k}\left(\frac{1}{T_{1}}-\frac{1}{T_{2}}\right)\right\} \\ a_{i} & =\exp \left\{\beta\left(V_{2}-V_{1}\right)\right\} \end{aligned}$ | $a_{T}=\exp \left\{\frac{E_{a}}{k}\left(\frac{1}{\mathrm{~T}_{1}}-\frac{1}{\mathrm{~T}_{2}}\right)\right\}$ | 231 pcs/1137 h $341 \mathrm{pcs} / 1000 \mathrm{~h}$ | $\begin{array}{\|c\|} 231 \mathrm{pcs} / 1000 \mathrm{~h} \\ (1394 \mathrm{~h}) \end{array}$ |

NOTE If you have any questions regarding this correction form, please contact Japan Electronics and Information Technology Industries Association (JEITA).
(https://www.jeita.or.jp/cgi-bin/form/form.cgi) *Sorry Japanese form only.

